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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/784,585	LONG ET AL.	
Examiner	Art Unit	
B. Chen	1762	

SEARCHED			
Class	Subclass	Date	Examiner
updated	previous	4/6/2007	вс
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
427	248.1	4/6/2007	вс
427	255.6	4/6/2007	вс

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
east	4/5/2007	ВС
referred to related applications 11/134654, 10/954940, 10/945941	4/5/2007	ВС
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